Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/780,276	TILKE ET AL.	
Examiner	Art Unit	
Thien F. Tran	2811	

	SEAR	CHED	
Class	Subclass	Date	Examiner
438	205, 309	4/28/2005	тт
438	313, 322	4/28/2005	TT
438	323, 340	4/28/2005	П
257	552-555	4/28/2005	ΤΤ

	RENCE SEARCHED		
Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
EAST		4/28/2005	TΤ